

四庫全書

		Subclass	ISSUE CLASSIFICATION
		Class	

PATENT NUMBER

U.S. UTILITY Patent Application

O.I.P.E.

PATENT DATE

APPLICATION NO. 09/905536	CONT/PRIOR D	CLASS 250	SUBCLASS 287	ART UNIT 2881 2853	EXAMINER LAM NGUYEN
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Mr. Gerald Dykstra

Gas cluster ion beam size diagnostics and workpiece processing

TITLE

ISSUING CLASSIFICATION

ORIGINAL

CROSS REFERENCE(S)

Continued on Issue Slip Inside File Jacket

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